Product Preview

Small Signal MOSFET

-20 V, -127 mA, Single P-Channel, XDFN3 0.62 x 0.42 x 0.4 mm Package

Features

- Low Profile Ultra Small Package, XDFN3 (0.62 x 0.42 x 0.4 mm) for Extremely Space–Constrained Applications
- -1.5 V Gate Drive
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Small Signal Load Switch
- High Speed Interfacing
- Level Shift

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V_{DSS}	20	V	
Gate-to-Source Voltage			V_{GS}	±8	V	
Continuous Drain	Steady	T _A = 25°C	I _D	-127	mA	
Current (Note 1)	State	T _A = 85°C		-91		
	t ≤ 5 s	T _A = 25°C		-146		
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	125	mW	
	t ≤ 5 s			166		
Pulsed Drain Current	t _p = 10 μs		I _{DM}	-488	mA	
Operating Junction and Storage Temperature			T_J , T_{STG}	–55 to 150	°C	
Source Current (Body Diode) (Note 2)			Is	200	mA	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Surface-mounted on FR4 board using the minimum recommended pad size, or 2 mm², 1 oz Cu.
- 2. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%

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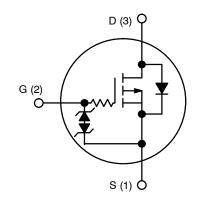


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V _{(BR)DSS}	R _{DS(on)} MAX	I _D Max
	5.0 Ω @ -4.5 V	
	5.5 Ω @ -3.3 V	
-20 V	6.0 Ω @ -2.5 V	–127 mA
	7.0 Ω @ –1.8 V	
	10 Ω @ -1.5 V	

P-CHANNEL MOSFET



MARKING DIAGRAM





XDFN3 CASE 711BH

D = Specific Device Code
M = Date Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NTNS31350PZTCG	XDFN3 (Pb-Free)	8000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

Downloaded from Arrow.com.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	998	°C/W
Junction-to-Ambient – $t \le 5$ s (Note 3)	$R_{\theta JA}$	751	C/VV

^{3.} Surface–mounted on $\overline{FR4}$ board using the minimum recommended pad size, or 2 mm², 1 oz Cu.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS	•				•			
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-20			V	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = -5 \text{ V}$	T _J = 25°C			-50	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = -16 \text{ V}$	T _J = 25°C			-100	nA	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm$	5 V			±100	nA	
ON CHARACTERISTICS (Note 4)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -25$	50 μΑ	-0.4		-1.0	V	
		$V_{GS} = -4.5 \text{ V}, I_D = -100 \text{ mA}$			2.1	5.0	Ω	
	R _{DS(on)}	$V_{GS} = -3.3 \text{ V}, I_D = -100 \text{ mA}$			2.4	5.5		
Drain-to-Source On Resistance		$V_{GS} = -2.5 \text{ V}, I_D = -50 \text{ mA}$			2.7	6.0		
		$V_{GS} = -1.8 \text{ V}, I_D = -20 \text{ mA}$			3.6	7.0		
		$V_{GS} = -1.5 \text{ V}, I_D = -10 \text{ mA}$			4.2	10		
Forward Transconductance	9FS	$V_{DS} = -5 \text{ V}, I_D = -125 \text{ mA}$			0.35		S	
Source-Drain Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = -10 mA			-0.6	-1.0	V	
CHARGES & CAPACITANCES	•				•			
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, freq} = 1 \text{ MHz, } V_{DS} = -15 \text{ V}$			12.8			
Output Capacitance	C _{OSS}				2.8		pF	
Reverse Transfer Capacitance	C _{RSS}				2.0			
SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 4)								
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -4.5 \text{ V}, V_{DD} = -15 \text{ V},$ $I_{D} = 200 \text{ mA}, R_{G} = 2 \Omega$			37			
Rise Time	t _r				71			
Turn-Off Delay Time	t _{d(OFF)}				280		ns	
Fall Time	t _f				171			

^{4.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

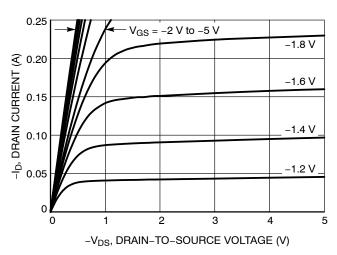


Figure 1. On-Region Characteristics

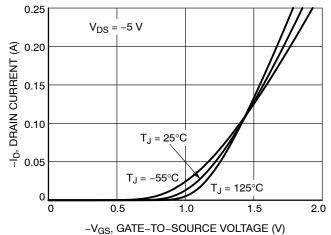


Figure 2. Transfer Characteristics

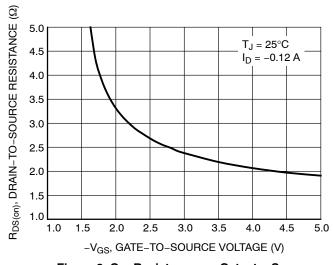


Figure 3. On-Resistance vs. Gate-to-Source Voltage

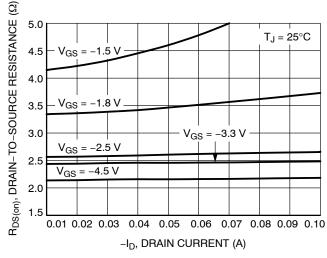


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

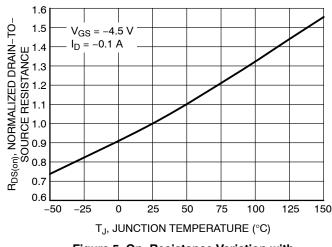


Figure 5. On-Resistance Variation with Temperature

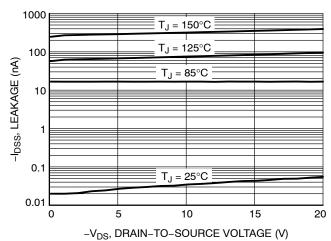


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

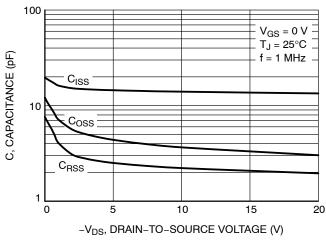


Figure 7. Capacitance Variation

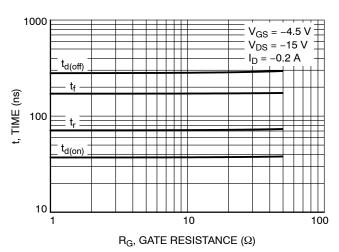


Figure 8. Resistive Switching Time Variation vs. Gate Resistance

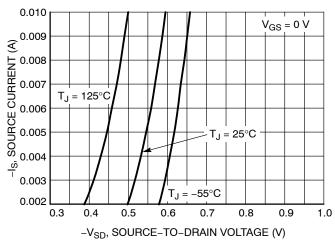


Figure 9. Diode Forward Voltage vs. Current

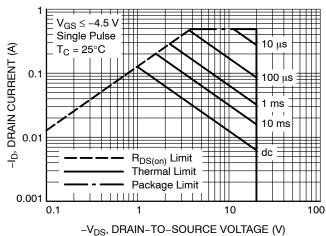


Figure 10. Maximum Rated Forward Biased Safe Operating Area

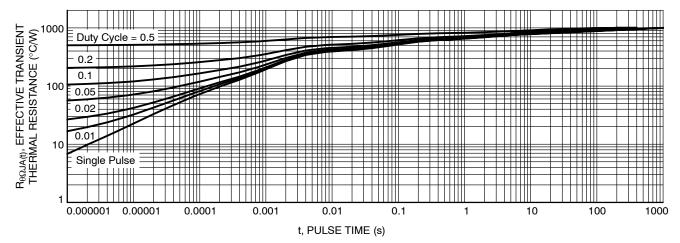
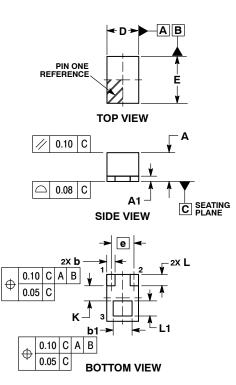


Figure 11. Thermal Response

PACKAGE DIMENSIONS

XDFN3 0.42x0.62, 0.3P CASE 711BH **ISSUE O**



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
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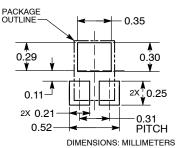
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- COPLANARITY APPLIES TO THE PLATED TERMI-NALS

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.33	0.38	0.43	
A1		-	0.07	
b	0.05	0.11	0.17	
b1	0.20	0.25	0.30	
D	0.32	0.42	0.52	
E	0.52	0.62	0.72	
е	0.30 BSC			
L	0.09	0.15	0.21	
L1	0.15	0.20	0.25	
K	0.20 REF			

RECOMMENDED **SOLDER FOOTPRINT***



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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